

| | | | |
|-----------------------------------|---------------------------------------|---|-------------|
| Notice of References Cited | Application/Control No. 10/588,760 | Applicant(s)/Patent Under Reexamination KIMURA ET AL. | |
| | Examiner Paresh Patel | Art Unit 2829 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|---------------------|----------------|
| * | A | US-6,447,308 | 09-2002 | McCarthy et al. | 439/91 |
| * | B | US-7,059,874 | 06-2006 | Weiss, Roger E. | 439/91 |
| * | C | US-5,818,700 | 10-1998 | Purinton, Donald L. | 361/760 |
| * | D | US-5,317,255 | 05-1994 | Suyama et al. | 324/754 |
| * | E | US-5,109,596 | 05-1992 | Driller et al. | 29/705 |
| * | F | US-4,740,657 | 04-1988 | Tsukagoshi et al. | 174/88R |
| | G | US- | | | |
| | H | US- | | | |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | W | |
| | X | |

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.